## 14. TEST SETUP PHOTOGRAPHS

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Figure 14-1 Test Setup for Wireless Device

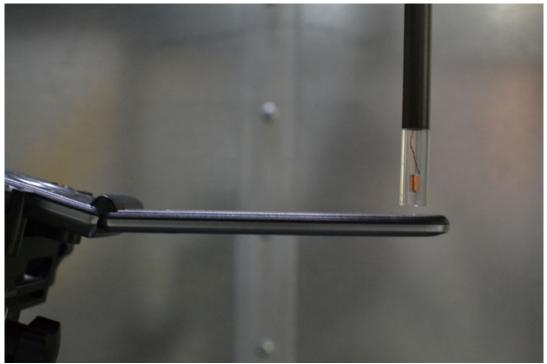


Figure 14-2 Test Setup for Wireless Device

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Radial (Transverse)

Figure 14-3 **T-Coil Scan Overlay Magnetic Field Distributions** 

Note: Final measurement locations are indicated by a cursor on the contour plots.

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